

# Search Notes



Application/Control No.

10/537,910

Examiner

Randall Chin

Applicant(s)/Patent under Reexamination

SHIN, HYO-SOON

Art Unit

1744

## SEARCHED

Class	Subclass	Date	Examiner
15	191.1	↓	↓
15	192	↓	↓
15	193	3/22/2006	RC
UPDATED	SPEH	8/15/06	RC

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
EAST, OCR, EPO, JPO, DERWENT	↓	↓
Inventor name search	3/22/2006	RC